

## MC-28AA-M3A-H-1212-B COB Datasheet

### Applications

- Spot lighting
- Down lighting
- Recessed fixtures
- Can lighting

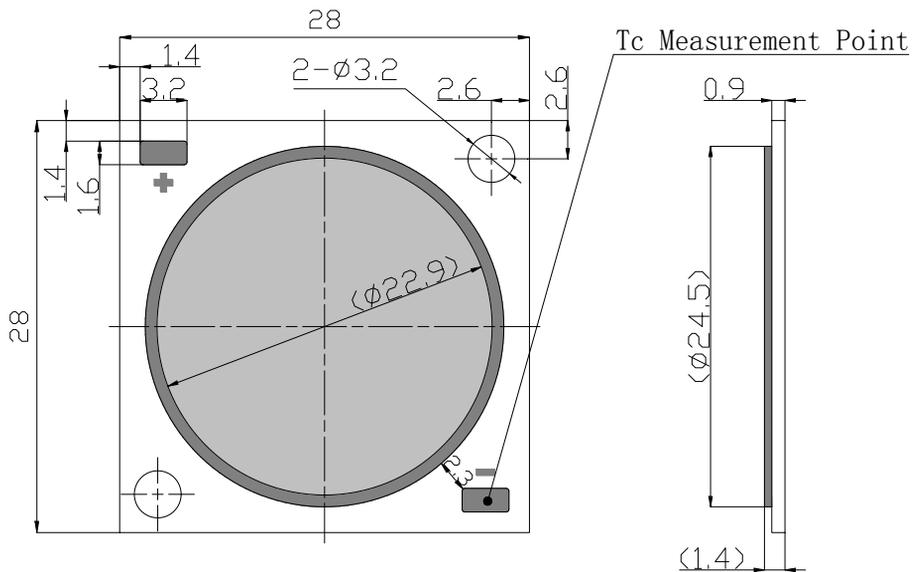


### Naming Conventions

MC - 28AA - M3A - H - 1212 - B  
 (1)            (2)    (3)    (4)

- (1) COB Series
- (2) CCT Range
- (3) CRI Range
- (4) Chip Array: 12 series, 12 parallel

### Package Dimensions



1. All dimensions in millimeters.
2. Tolerance is  $\pm 0.3$ mm unless otherwise noted.
3. The information in this document is subject to change without notice.

### Absolute Maximum Ratings

Item	Symbol	Absolute Maximum Rating	Unit
Forward current	If	2760	mA
Peak Power	-	98	W
Reverse Current	Ir	1	mA
Operating Temperature	Topr	-30~85	°C
Storage Temperature	Tstg	-40~100	°C
Hand soldering condition	Tsld	3.5sec@350°C	sec
Case Temperature	Tc	100	°C
LED Junction Temperature	Tj	125	°C
Temperature of central silicon Surface	Ts	125@IRDA Test	°C

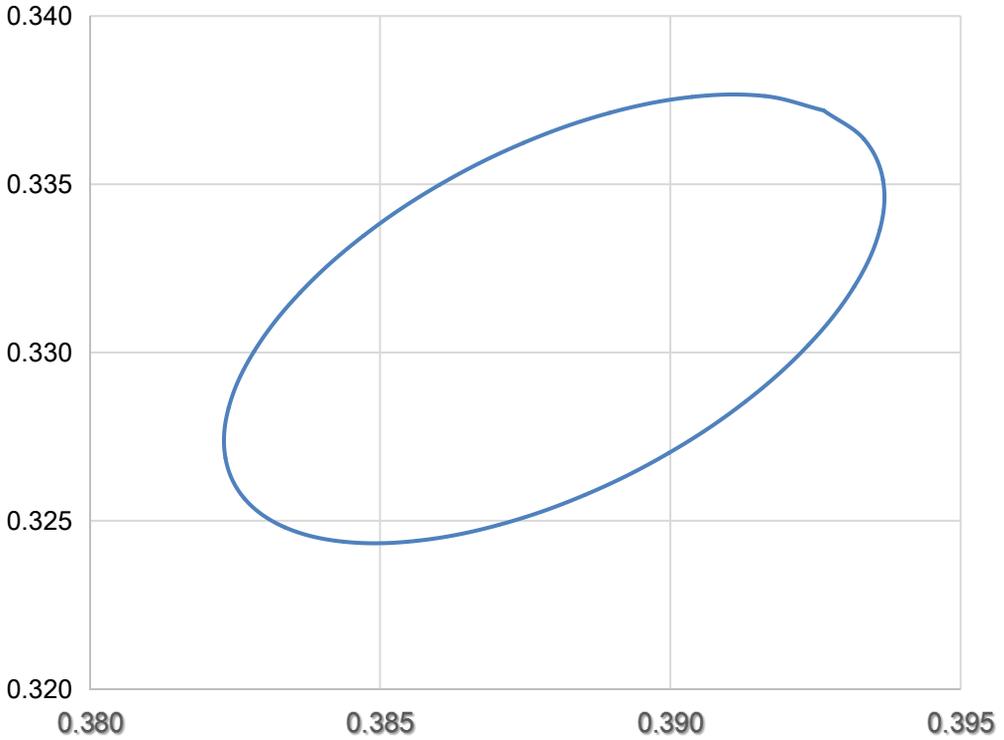
### Characteristics (Tc=25°C)

Part Number	Nominal CCT	CRI(Ra)		Luminous flux (lm)		Forward Current (mA)	Voltage (V)			Thermal Resistance Rj-c (°C/W)
		Min.	Typ.	Min.	Typ.		Min.	Typ.	Max.	
MC-28AA-M3A-H-1212-B	V3300K	80		3780	4200	1440	33.6		40.8	0.38

Notes:

1. Luminous flux is measured with an accuracy of +/- 5 %.
2. CRI is measured with an accuracy of +/- 1
3. Some color and CRI bins may have limited availability, please contact us before ordering.
4. All measurements were made under the standardized environment of Shineon.

Chromaticity Bins

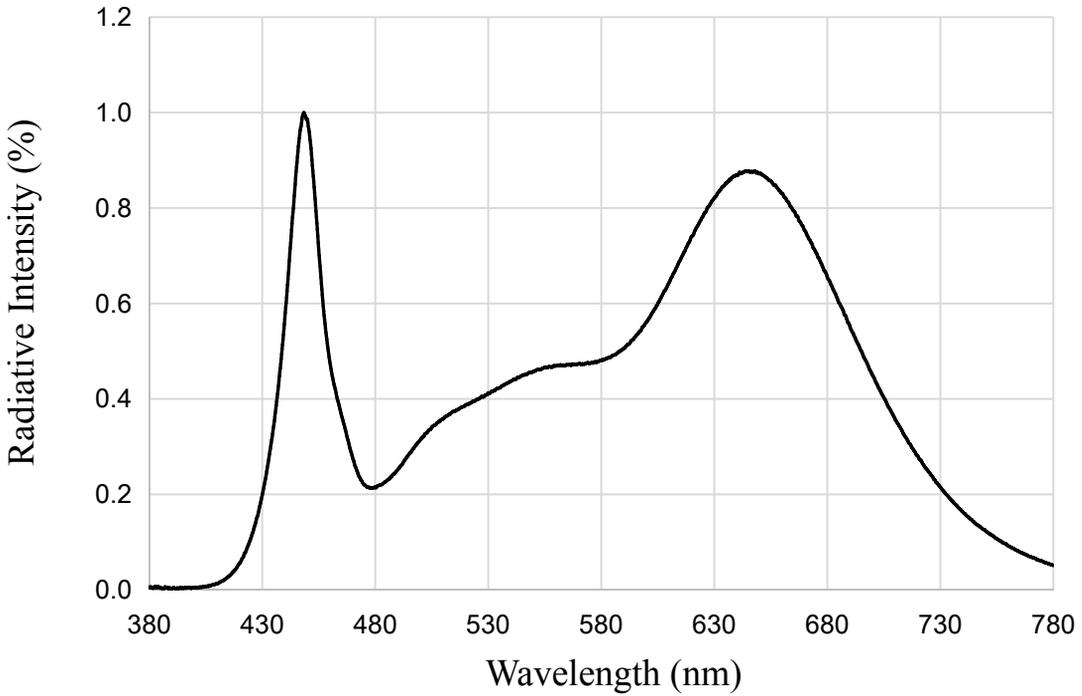


Bin Code	Nominal CCT	Center Point		Oval parameter		
		x	y	a	b	Theta°
M3A3	M3300K (3step)	0.388	0.331	0.00774	0.00411	53.17

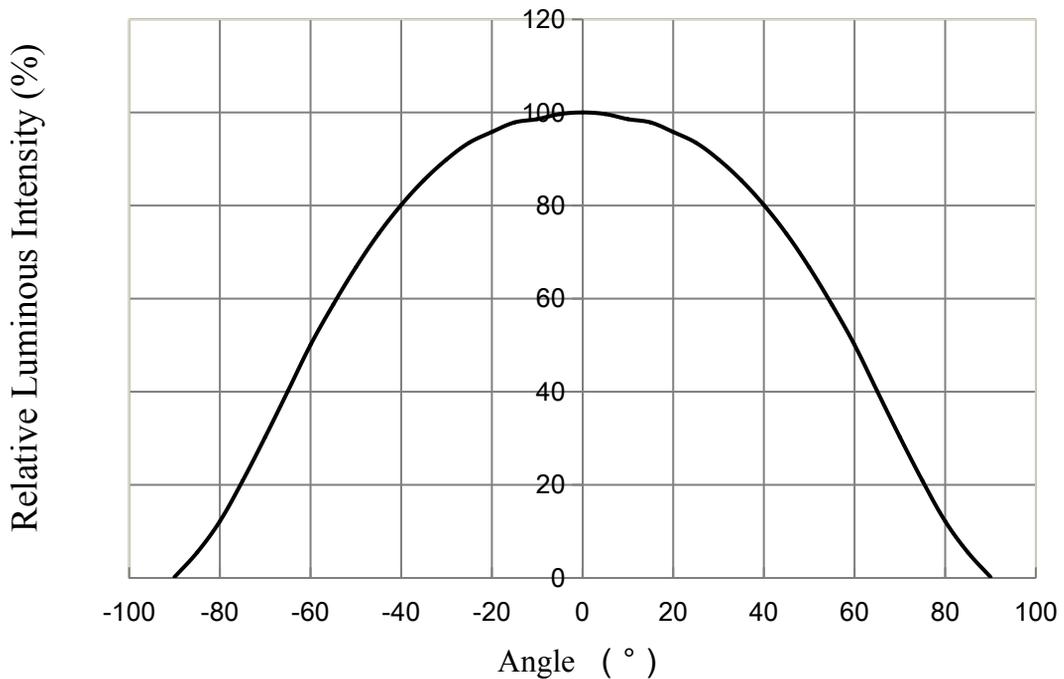
Notes:

1. 5% tolerance for luminous intensity may be caused by measurement inaccuracy.
2. Measurement Uncertainty of the Forward Voltage : +/-3%
3. Chromaticity coordinate bins are measured with an accuracy of +/-0.005.

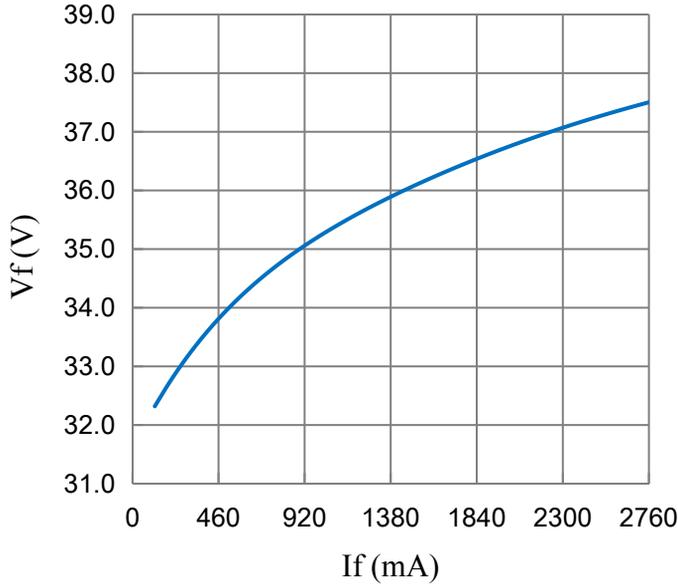
Typical Relative Spectral Power Distribution (Tc=25°C, If=1440mA)



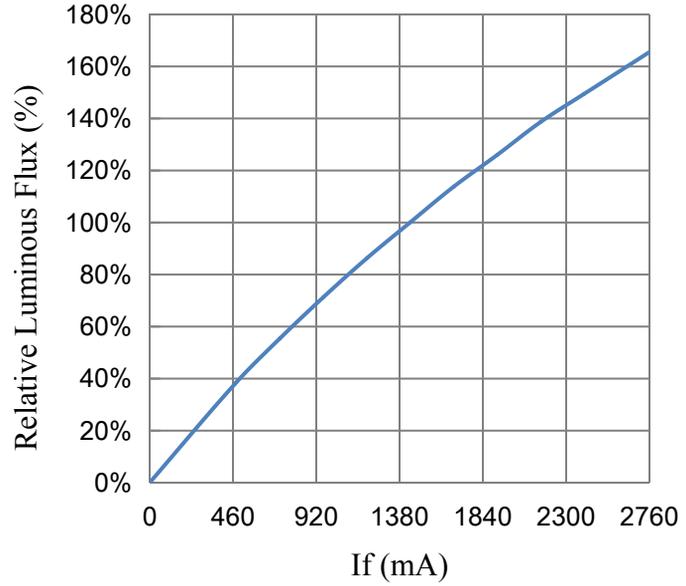
Typical Spatial Distribution (Tc=25°C, If=1440mA)



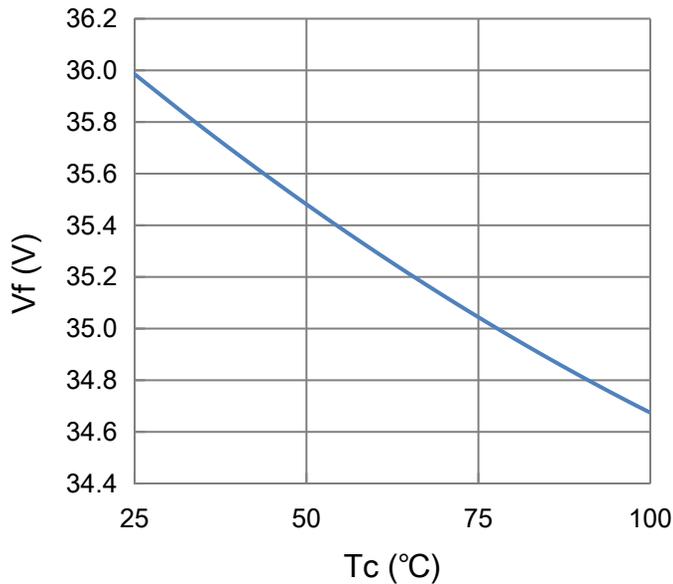
**Forward Current vs. Forward Voltage**  
( $T_c=25^\circ\text{C}$ )



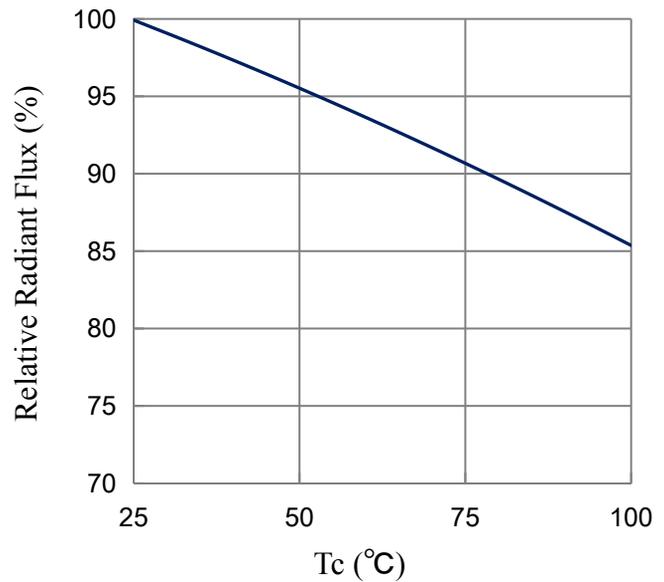
**Forward Current vs. Relative Luminous Flux**  
( $T_c=25^\circ\text{C}$ )



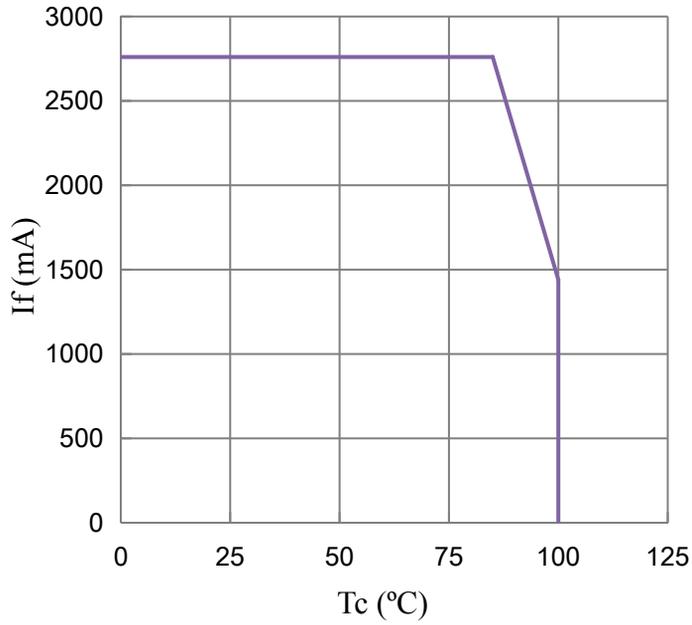
**Case Temperature vs. Forward Voltage**  
( $I_f=1440\text{mA}$ )



**Case Temperature vs. Relative Radiant Flux**  
( $I_f=1440\text{mA}$ )



### Case Temperature vs. Allowable Forward Current



## Reliability

### (1)Details of the tests

No.	Test Item	Reference Standard	Test Condition	Test Duration	Defective	Sample Size
1	High Temperature Operating Life	JESD22-A108	Tc=85°C, Typical IF	1000hr	0	10
2	Low Temperature Operating Life	JESD22-A108	Ta=-40°C, Typical IF	1000hr	0	10
3	Temperature Shock	MIL-STD-202G Method 107G	-40°C ↔ 100°C	100cycles	0	10
4	High Temperature Storage	JESD22-A103	100°C	1000hr	0	10
5	Temperature Humidity Storage	JEITA ED-4701 100 103	60°C, 90%RH	1000hr	0	10

### (2)Judgment Criteria of Failure for Reliability Test

(Ta=25°C)

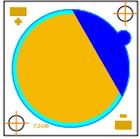
NO.	Measuring Item	Symbol	Measuring Condition	Judgment Criteria for Failure
1	Forward Voltage	Vf	IF=1440mA	>U X 1.1
2	Total Luminous Flux	∅v	IF=1440mA	<S X 0.85

Notes:

U defines the upper limit of the specified characteristics. S defines the initial value.

PACKING

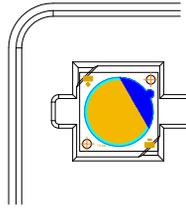
COB 28AA



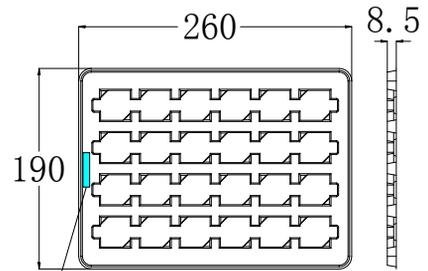
Protective film on LES



COB 28AA



24 pcs of device per tray



Label 1



6 trays in an anti-static bag, with one empty tray on top.

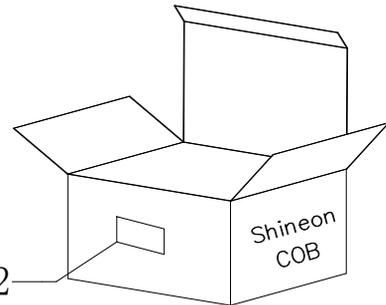
The set of 6 trays is packed up with a vacuum bag.

7 bags per box



Notes:

Remove the protective film before use in the first time.



Label 2

840 pcs of device per box